

PLANT LEAF SEGNENTATION FOR ESTIMATING PHENOTYPIC TRAITS

Introduction

- Phenotyping is a set of methodologies for recording, analyzing and measuring characteristic traits of a plant resulting from genetic and environmental factors
- Many phenotyping methods are invasive, thus damaging the plant when measurements are made
- Imaging technologies provide a non-invasive and an effective way for data collection and plant trait estimation
- We describe a method to segment individual leaves and extract phenotypic traits of plants from UAV images





Acknowledgement

The information, data, or work presented herein was funded in part by the Advanced Research Projects Agency-Energy (ARPA-E), U.S. Department of Energy, under Award Number DE-AR0000593. The views and opinions of the authors expressed herein do not necessarily state or reflect those of the United States Government or any agency thereof. Address all correspondence to Edward J. Delp, ace@ecn.purdue.edu

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Leaf Segmentation

- We transform the image into polar coordinates around the plant center
- We obtain the mask of leaf pixels by thresholding in HSV color space
- A basic element, the slice, is introduced to analyze the leaf morphology A slice is a connected set of coordinates in the foreground mask at a constant radius *r* level
- We represent the leaf slices in a hierarchical way By vertically stacking leaf slices, we obtain a leaf shape
- We reconstruct a leaf shape by combining the tips with all their ancestors
- We define an observed leaf shape X as $X = \{x_1, x_2, ..., x_{L_X}\}$

where L_X is the number of slices in the leaf shape X Each slice x_m , $m = 1, ..., L_X$ is one pixel thick, and $\boldsymbol{\theta}(x_m)$ degrees wide • We define the set

$$A = \{X_1, X_2, \ldots,$$

containing all *N* reconstructed leaf shapes X_i , i = 1, ..., N



Image of two leaves



in hierarchy



Leaf Modeling

- We match leaf shapes with shape models to avoid noise and occlusion
- A shape model $S \in D$, consists of a set of slices:

 $S = \{y_1, y_2, ..., y_{L_S}\}$

where L_S is the number of slices in the shape model S, and the finite set *D* contains all our shape models

• The width W_m , $m = 1, ..., L_S$ of the *m*-th slice, y_m , in shape model S is modeled as random variable with normal distribution $p_{W_m}(w) = \mathcal{N}(\mu_m, \sigma_m^2)$

where $\mu_{\rm m}$ and σ_m^2 are the mean and variance, respectively We call $p_{W_m}(\cdot)$ the slice matching probability. The parameters μ_m and σ_m^2 of the model are obtained from a pyramidal model of the leaf shapes

• We obtain the match score of an observed leaf shape $X \in A$ with a possible shape model $S \in D$ as

$$f(X,S) = \sum_{m=1}^{L_S} w_{m,S} p_V$$

where $w_{m,S}$ is the weight for the *m*-th slice of the shape model S

 X_N

Leaf shape 1 in blue



in yellow

 $W_m(\boldsymbol{\theta}(x_m))$

• We assume that all slices are equally weighted and normalized, so

the model with maximum match score:



Two leaves from overlapping plants





Original image

Segmentation Shape model of a leaf of the leaf

Experimental Results

Total number of leaves

True positives

False positives

False negatives

- We presented a method to segment leaves of sorghum plants and obtain phenotypic traits from UAV imagery
- Future work will refine our shape models and investigate optimal weights for shape matching. We are collecting much more imagery so that we can also investigate deep learning methods



$$w_{m,S} = \frac{1}{L_S}, \qquad m = 1, \dots, L_S$$

• The shape model \hat{S} that best describes the observed leaf shape X is

$$\hat{S} = \operatorname*{argmax}_{S \in D} f(X, S)$$



A possible shape model



The matched shape model of the segmented leaf





Leaves segmented in of leaves in colors



Shape model colors

82	
57	
18	
25	
	57 18

Precision	70 %
Recall	76 %

• Traits estimated include width and length of each leaf, leaf count and LAI (Leaf Area Index) of individual plants

Conclusion